

## Features

- Typ. R<sub>DS(on)</sub> = 188 mΩ
- Ultra Low Gate Charge (Typ. Q<sub>q</sub> = 78 nC)
- Low E<sub>oss</sub> (Typ. 7.5 uJ @ 400 V)
- Low Effective Output Capacitance (Typ. C<sub>oss(eff.)</sub> = 304 pF)
- 100% Avalanche Tested
- RoHS Compliant
- · ESD Improved Capability

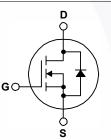
# Applications

- AC-DC Power Supply
- LED Lighting

# Description

SuperFET<sup>®</sup> II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Parameter			FCPF220N80	Unit	
V <sub>DSS</sub>	Drain to Source Voltage		800	V		
V <sub>GSS</sub>		- DC	- DC		V	
	Gate to Source Voltage	- AC	(f >1 Hz)	±30	V	
ID	Drain Current	- Continuous (T <sub>C</sub> = 25 <sup>o</sup> C)		23*	Α	
		- Continuous (T <sub>C</sub> = 100 <sup>o</sup> C)		14.6*	A	
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)		57*	Α	
E <sub>AS</sub>	Single Pulsed Avalanche Energy		(Note 2)	645	mJ	
I <sub>AR</sub>	Avalanche Current	(Note 1)	4.6	Α		
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	27.8	mJ		
dv/dt	MOSFET dv/dt			100	Mag	
	Peak Diode Recovery dv/dt (Note 3)			20	V/ns	
P <sub>D</sub>	Dower Dissinction	(T <sub>C</sub> = 25°C)		44	W	
	Power Dissipation	- Derate Above 25°C		0.35	W/ºC	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to +150	°C	
Τ <sub>L</sub>	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	°C	

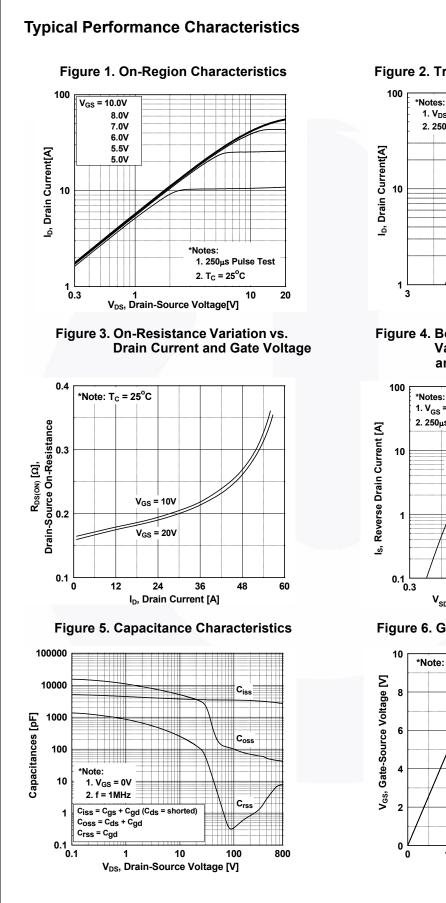
## Thermal Characteristics

Symbol	Parameter	FCPF220N80	Unit
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	2.8	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	°C/W

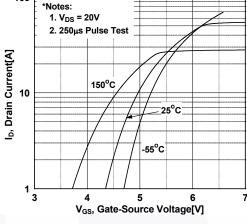
May 2015

Т
$\overline{\mathbf{O}}$
D
N
2
¥
6
õ
ī
-
~
Ò
÷
a
ñ
Z
e
ž
Sup
5
ŏ
Ĩ
Ē
Щ
B
<u> </u>
=
Ζ
ō
ž
¥
ΈE
<u> </u>
•

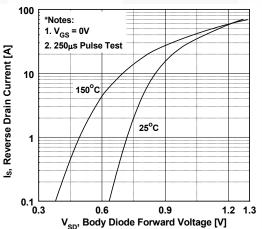
Symbol Off Character BV <sub>DSS</sub> D ABV <sub>DSS</sub> B	Characteristics T <sub>C</sub> = 25 <sup>o</sup> Parameter	TO-220F	Packing Method     Tube     erwise noted.     Test Conditions	N/A		N/A	50	units
Symbol   Off Character   BV <sub>DSS</sub> D   ΔBV <sub>DSS</sub> B	Parameter ristics	C unless oth						
Symbol   Off Character   BV <sub>DSS</sub> D   ΔBV <sub>DSS</sub> B	Parameter ristics	C unless oth						
Dff Character BV <sub>DSS</sub> D ABV <sub>DSS</sub> B	ristics		Test Conditions		Mim	Turn	Max	l lmit
BV <sub>DSS</sub> D ABV <sub>DSS</sub> B					Min.	Тур.	Max.	Unit
ΔBV <sub>DSS</sub> B	rain to Source Preskdown Malta							
	rain to Source preakdown voltag	je V <sub>G</sub>	<sub>S</sub> = 0 V, I <sub>D</sub> = 1 mA, T <sub>J</sub> =	25°C	800	-	-	V
	Breakdown Voltage Temperature Coefficient		$I_D = 1$ mA, Referenced to 25°C		-	0.8	-	V/ºC
. 7	ara Cata Valtaga Drain Current	VDS	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 640 V, T <sub>C</sub> = 125°C		-	-	25	
I <sub>DSS</sub>	ero Gate Voltage Drain Current	VDS			-	-	250	μΑ
I <sub>GSS</sub> G	Gate to Body Leakage Current		V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V		-	-	±100	nA
On Character	istics							
	ate Threshold Voltage	Vo	<sub>S</sub> = V <sub>DS</sub> , I <sub>D</sub> = 2.3 mA		2.5		4.5	V
	tatic Drain to Source On Resistar	-	$s = 10 \text{ V}, I_D = 11.5 \text{ A}$		-	188	220	mΩ
	orward Transconductance		$s = 20 \text{ V}, I_D = 11.5 \text{ A}$		-	25	-	S
9F5			5 _0 ,, 0			20		0
Dynamic Cha	racteristics							
C <sub>iss</sub> In	put Capacitance		V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, f = 1 MHz		-	3430	4560	pF
	utput Capacitance				-	100	135	pF
	everse Transfer Capacitance	T =			-	0.3	-	pF
	utput Capacitance	VD	<sub>S</sub> = 480 V, V <sub>GS</sub> = 0 V, f	= 1 MHz	-	49	-	pF
	ffective Output Capacitance		<sub>S</sub> = 0 V to 480 V, V <sub>GS</sub> =		-	304	-	pF
000(011)	otal Gate Charge at 10V		V <sub>DS</sub> = 640 V, I <sub>D</sub> = 23 A, V <sub>GS</sub> = 10 V		-	78	105	nC
9(101)	ate to Source Gate Charge				-	16	-	nC
90	Gate to Drain "Miller" Charge		(Note 4)			28	-	nC
	quivalent Series Resistance	f =	1 MHz		-	0.78	-	Ω
				I				1
	aracteristics					- T T		
=(=)	urn-On Delay Time		$V_{DD}$ = 400 V, I <sub>D</sub> = 23 A, V <sub>GS</sub> = 10 V, R <sub>g</sub> = 4.7 Ω		-	27	64	ns
•	urn-On Rise Time				- /	19	48	ns
a(011)	urn-Off Delay Time	V GS			-	75	160	ns
t <sub>f</sub> Ti	urn-Off Fall Time			(Note 4)	-	2.6	15	ns
Drain-Source	<b>Diode Characteristics</b>							
	aximum Continuous Drain to Sou	irce Diode Ec			-	_	23	А
					-	_	57	A
OW	Maximum Pulsed Drain to Source Diode Drain to Source Diode Forward Voltage		$V_{GS}$ = 0 V, I <sub>SD</sub> = 23 A		-		1.2	V
	everse Recovery Time				-	560	1.2	ns
t <sub>rr</sub> Re	everse Recovery Charge		<sub>S</sub> = 0 V, I <sub>SD</sub> = 23 A, /dt = 100 A/µs	+		14	-	μC



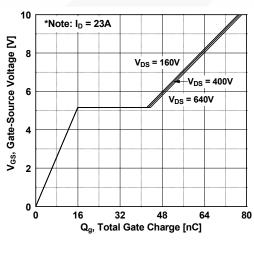
### Figure 2. Transfer Characteristics



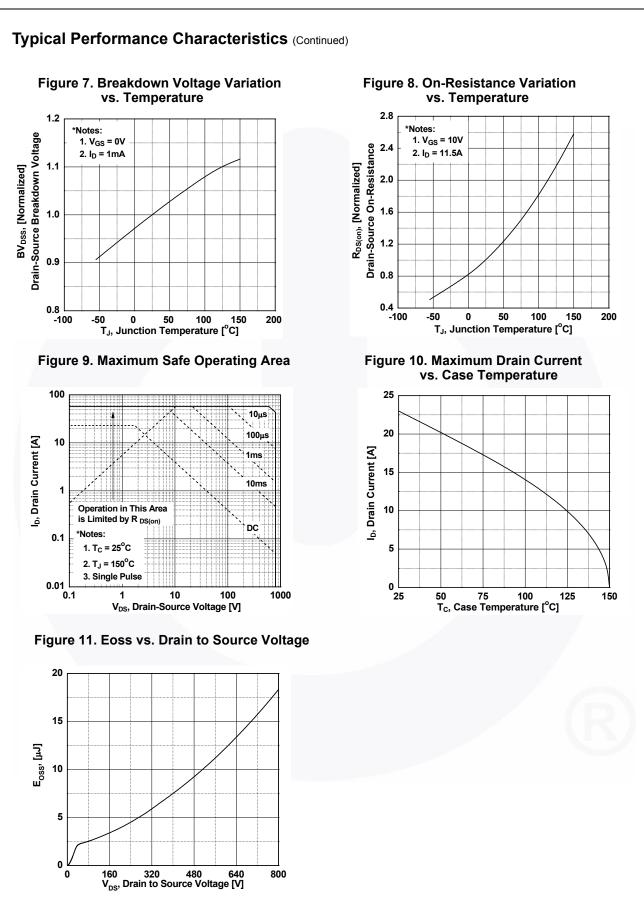




### Figure 6. Gate Charge Characteristics

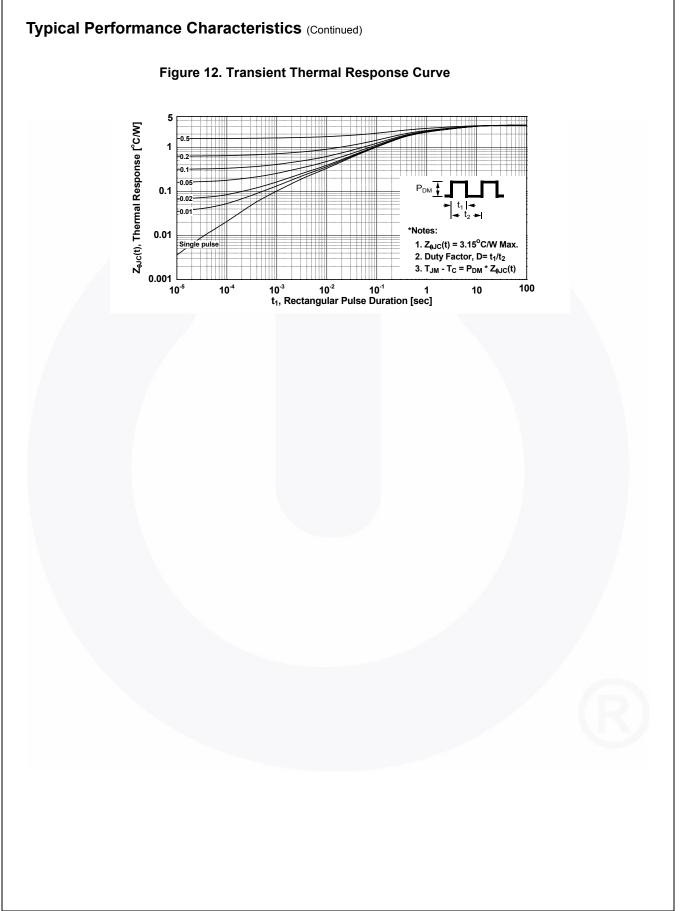


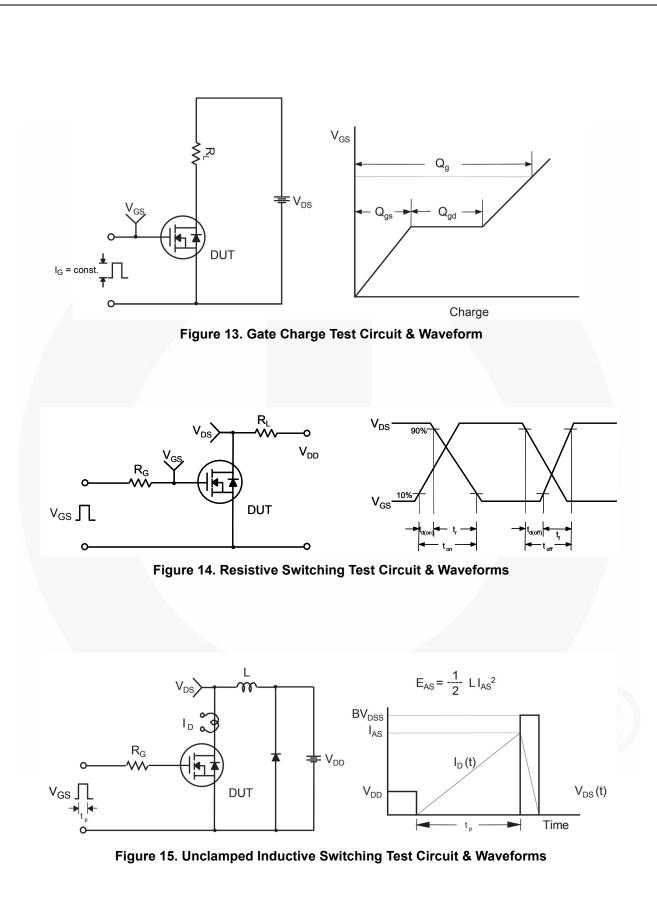




©2015 Fairchild Semiconductor Corporation FCPF220N80 Rev. 1.1

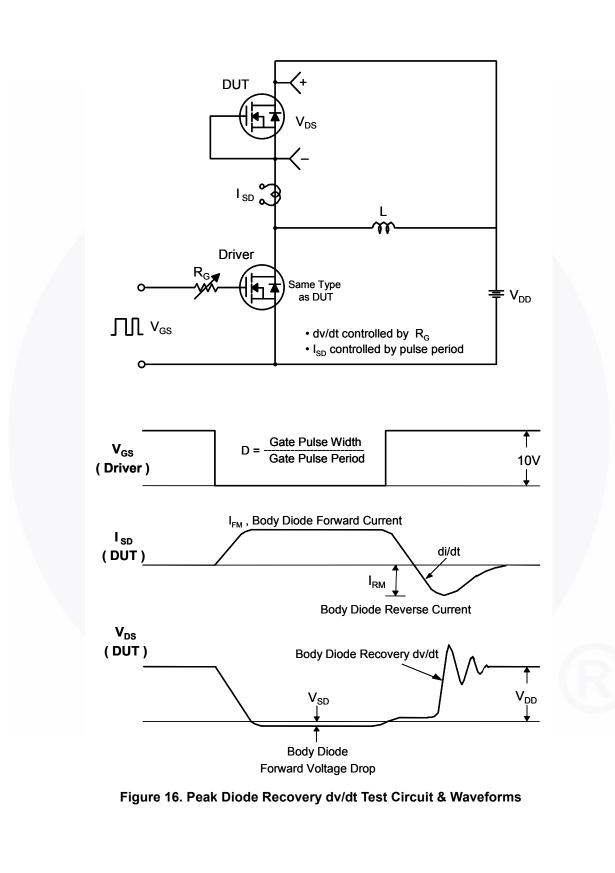
www.fairchildsemi.com

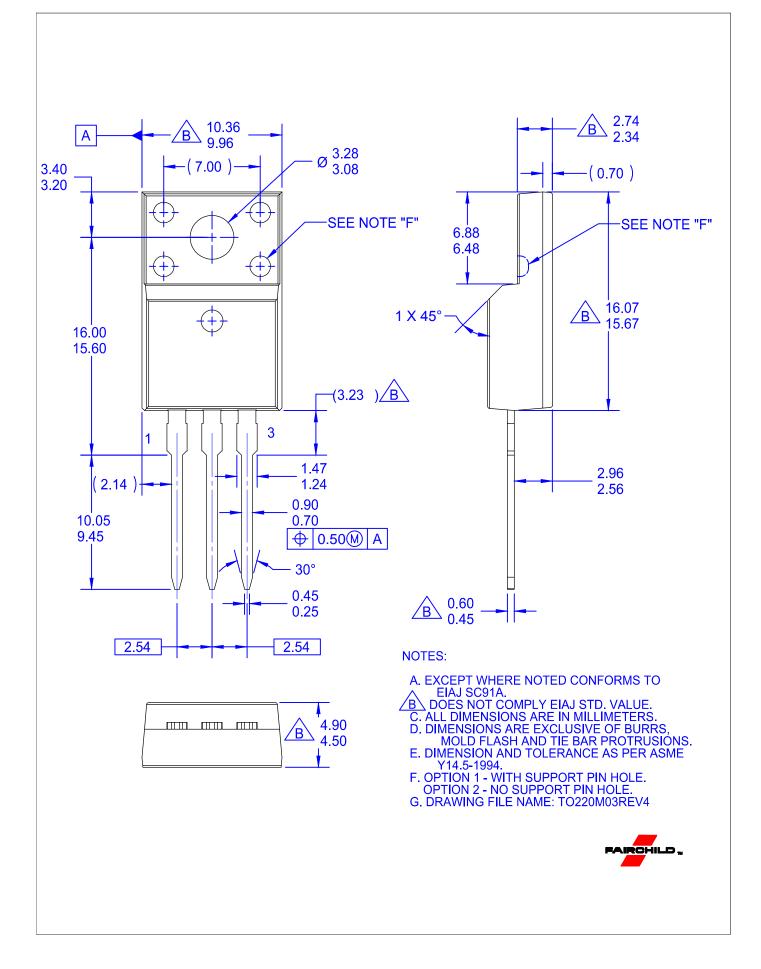




FCPF220N80 — N-Channel SuperFET<sup>®</sup> II MOSFET

FCPF220N80 — N-Channel SuperFET<sup>®</sup> II MOSFET







\* Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. TO OBTAIN THE LATEST, MOST UP-TO-DATE DATASHEET AND PRODUCT INFORMATION, VISIT OUR WEBSITE AT <u>HTTP://WWW.FAIRCHILDSEMI.COM</u>, FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

#### AUTHORIZED USE

Unless otherwise specified in this data sheet, this product is a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability. This product may not be used in the following applications, unless specifically approved in writing by a Fairchild officer: (1) automotive or other transportation, (2) military/aerospace, (3) any safety critical application – including life critical medical equipment – where the failure of the Fairchild product reasonably would be expected to result in personal injury, death or property damage. Customer's use of this product is subject to agreement of this Authorized Use policy. In the event of an unauthorized use of Fairchild's product, Fairchild accepts no liability in the event of product failure. In other respects, this product shall be subject to Fairchild's Worldwide Terms and Conditions of Sale, unless a separate agreement has been signed by both Parties.

#### ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Terms of Use

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

### PRODUCT STATUS DEFINITIONS

Definition of Terms					
Datasheet Identification	Product Status	Definition			
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.			
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.			
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.			

Rev. 177